Degradation sources in the SolACES instrument – and how to correct them

Christian Erhardt, Dr. Marcel Pfeifer, Dr. Raimund Brunner, Dr. Gerhard Schmidtke Fraunhofer IPM, Freiburg, Germany Dr. Bernd Nikutowski LIM / University of Leipzig, Germany



SolACES

- degradation sources
- measurement systems in SolACES
- Level 3 data product
- differential degradation
- changes in the overall evaluation
- double calibration method and results
- conclussion





SolACES – degradation sources

- in 1972 Dr. Gerhard Schmidtke used a Ni63 source to calibrate an EUV-detector
- in the figure the changes in the countrate at constant flux are shown.



Figure 13a: Count rate changes of a Bendix MEM 306 multiplier using a nickel 63 radioactive beta source (Schmidtke et al., 1975).



SolACES – degradation sources

- in 1972 Dr. Gerhard Schmidtke used a Ni63 source to calibrate an EUV-detector
- in the figure the changes in the efficiency are shown.
- The changes in the efficiency correlate very well with temperature differences measured.



Figure 13a: Count rate changes of a Bendix MEM 306 multiplier using a nickel 63 radioactive beta source (Schmidtke et al., 1975).



Figure 13b: Trace of the temperature changes during the mission of AEROS-A to be compared with the count rate changes during the same time (Figure 13a).



SolACES – degradation sources

- the figure on the right shows measurements of Ly- α
- 5 channels with 5 equal detectors, measuring at the same time and showing differences of a factor 2.6
- 5 different results \rightarrow 5 different efficiency curves.





SolACES – measurement systems in **SolACES**





SolACES – Level 3 data product

- Level 2 contains of more than 500 spectra until the end of 2010
- Level 3 starts where Level 2 left off
 - differential degradation had to be corrected
 - → complete new set of parameters had to be developed after correction







SolACES – Level 3 product

- max count rates drop since the middle of 2010 rapidly
- This leads to degradation during the acquisition of a spectrum
- drop of efficiency during one spectrometer measurement between a 5% and 60% →this is called

differential degradation





- HV supplies the PSL
- incoming photons ionize the material and detach electrons
- over time the internal resistance of the PSL rises
- → it takes longer to replenish the PSL with electrons
- less electrons are generated from the PSL due to incoming photons



- effect is dependent on previous measurements:
 - strong lines degrade the PSL more, higher drop in efficiency
 - smaller lines degrade the PSL less and even regenerate the efficiency



- example of efficiency drop during a measurement at constant wavelength
- drop is dependent on incoming photons
- →on strong lines the spectrometer degrades more, on weak lines less or even recovers





- degradation is dependent on incoming photon flux→
- we use the differences in the countrate from point to point to estimate the degradation





The reciprocal of the cummulative sum is being fitted to the relative known degradation for the actual countrate





- correcting the spectra with the estimated degradation
- the correction leads to a different qualitative spectra
- all other corrections have to be applied to the new spectra





SolACES – changes in the overall evaluation

- dead time correction over the FWHM of the Hell line
- varying the dead time to fit the spectrometer resolution





SolACES – changes in the overall evaluation

- recalculating the relation from first optical order to second optical order
- comparison with theoretical simulation second optical order relation
- simulation and calculation have a Correlation of 99.483% for the wavelength region above 34nm.
- relation is difficult to calculate below 34nm





- The calibration is based on a simulation of the ionization currents inside the chamber
- the current is dependent on the incoming photon flux
- We choose a double calibration in order to simulate specific wavelength regions seperatly in this case with to AIC-filters





The calibration with AIC-17-23nm estimates the photon flux in the region from 16-29nm very exactly-> the current is dominated by this region

The calibration with AIC-17-52nm gives detail to the region above 29nm. Especially to the Hell line









The results after double calibration show very good correlation with an example spectra from SDO/EVE L3V4





SolACES – conclusion

- degradation is still a big challenge in the EUV-region
- we can estimate the differential degradation at fast changing countrates
- the methods will be applied in the Level 3 dataset that is soon be available
- we get promissing results with the double calibration method.

